

**Search Notes**

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Examiner

Bin Shen

Applicant(s)/Patent under  
Reexamination

TEICH ET AL.

Art Unit

1657

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
WEST		5/16/2007	BS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search.	5/16/2007	BS